Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SMITH, DEBRA | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,310,615	12-2007	Lewis, Charles J.	705/35
*	В	US-2005/0096927	05-2005	Mehta et al.	705/001
*	С	US-6,856,970	02-2005	Campbell et al.	705/35
*	D	US-2003/0097327	05-2003	Anaya et al.	705/37
*	E	US-2006/0082055	04-2006	Chen, Samuel	273/126.00R
*	F	US-2002/0004773	01-2002	Xu et al.	705/36
*	G	US-5,754,655	05-1998	Hughes et al.	705/70
*	н	US-2002/0046484	04-2002	Lundgren, Sharon	47/29.6
*	1	US-2002/0042795	04-2002	Smith, David	707/201
*	J	US-2003/0120619	06-2003	Osborn, Mark David	706/19
*	К	US-2006/0041493	02-2006	Schulze et al.	705/035
*	L	US-2003/0120619	06-2003	Osborn, Mark David	706/19
*	М	US-2006/0041493	02-2006	Schulze et al.	705/035

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				-	
	Q					-
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.